

BOLYMIN

**SPECIFICATIONS FOR
LCD MODULE**

MODEL NO.
BO12864GBNHH\$
VER.01



FOR MESSRS:

ON DATE OF:

APPROVED BY:

History of Version

Version	Contents	Date	Note
01	NEW VERSION	2010/03/23	SPEC.

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1. Numbering System

<u>B</u>	<u>O</u>	<u>12864</u>	<u>G</u>	<u>B</u>	<u>N</u>	<u>H</u>	<u>:</u>	<u>H</u>	<u>\$</u>
0	1	2	3	4	5	6	7	8	9

0	Brand	Bolymin	
1	Module Type	C= character type G= graphic type P= TAB/TCP type	O= COG type F= COF type L=PLED/OLED
2	Format	2002=20 characters, 2 lines 12232= 122 x 32 dots	
3	Version No.	A type	
4	LCD Color	G=STN/gray Y=STN/yellow-green PLED/yellow-green C=color STN,OLED/RGB	B=STN/blue,OLED/blue F=FSTN T=TN D=OLED/blue+yellow A=OLED/blue+yellow+green
5	LCD Type	R=positive/reflective P=positive/transflective	M=positive/transmissive N=negative/transmissive
6	Backlight type/color	L=LED array/ yellow-green H=LED edge/white R=LED array/red G=LED edge/yellow-green F=RGB array I=RGB edge Q=LED edge/red N=No backlight	D=LED edge/blue E=EL/white B=EL/blue C=CCFL/white Y=LED Bottom/yellow O=LED array/orange K=LED edge/green A=LED edge/amber
7	CGRAM Font (applied only on character type)	J=English/Japanese Font E=English/European Font G=Chinese(simple) F=Chinese(traditional)	C=English/Cyrillic Font H=English/Hebrew Font A=English/Arabic Font
8	View Angle/ Operating Temperature	B=Bottom/Normal Temperature H=Bottom/Wide Temperature U=Bottom/Ultra wide Temperature	T=Top/Normal Temperature W=Top/Wide Temperature C=9H/Normal Temperature E=Top/ultra wide temperature
9	Special Code	3=3 volt logic power supply n=negative voltage for LCD c=cable/connector xxx=to be assigned on datasheet	t=temperature compensation for LCD p=touch panel \$=RoHS

2. General Specification

(1) Mechanical Dimension

Item	Dimension	Unit
Number of Dots	128 x 64	dots
Module dimension (L x W x H)	76.0x 50.0 x 6.0 (MAX)	mm
View area	72.0x 39.0	mm
Active area	66.53 x 33.25	mm
Dot size	0.48x 0.48	mm
Dot pitch	0.52 x 0.52	mm

(2) Controller IC: ST7588T controller

(3) Temperature Range

	Wide
Operating	-20 ~+70°C
Storage	-30 ~+80°C

3. Absolute Maximum Ratings

Item	Symbol	Min	Typ	Max	Unit
Operating Temperature	T _{OP}	-20	-	+70	°C
Storage Temperature	T _{ST}	-30	-	+80	°C
Supply Voltage For Logic	V _{dd} -V _{ss}	-0.3	-	+3.6	V

4. Electrical Characteristics

Item	Symbol	Condition	Min	Typ	Max	Unit
Supply Voltage For Logic	V _{dd} -V _{ss}	—	2.4	3.0	3.3	V
Supply Voltage For LCD	V _o -V _{ss}	* Ta=-20°C Ta=25°C * Ta=+70°C	— — —	— 9.2 —	— — —	V
Input High Volt.	V _{IH}	—	0.7*V _{dd}	—	V _{dd}	V
Input Low Volt.	V _{IL}	—	V _{ss}	—	0.3*V _{dd}	V
Output High Volt.	V _{OH}	—	0.8*V _{dd}	—	V _{dd}	V
Output Low Volt.	V _{OL}	—	V _{ss}	—	0.2*V _{dd}	V
Supply Current	I _{dd}	V _{dd} =3.3V	—	0.5	—	mA

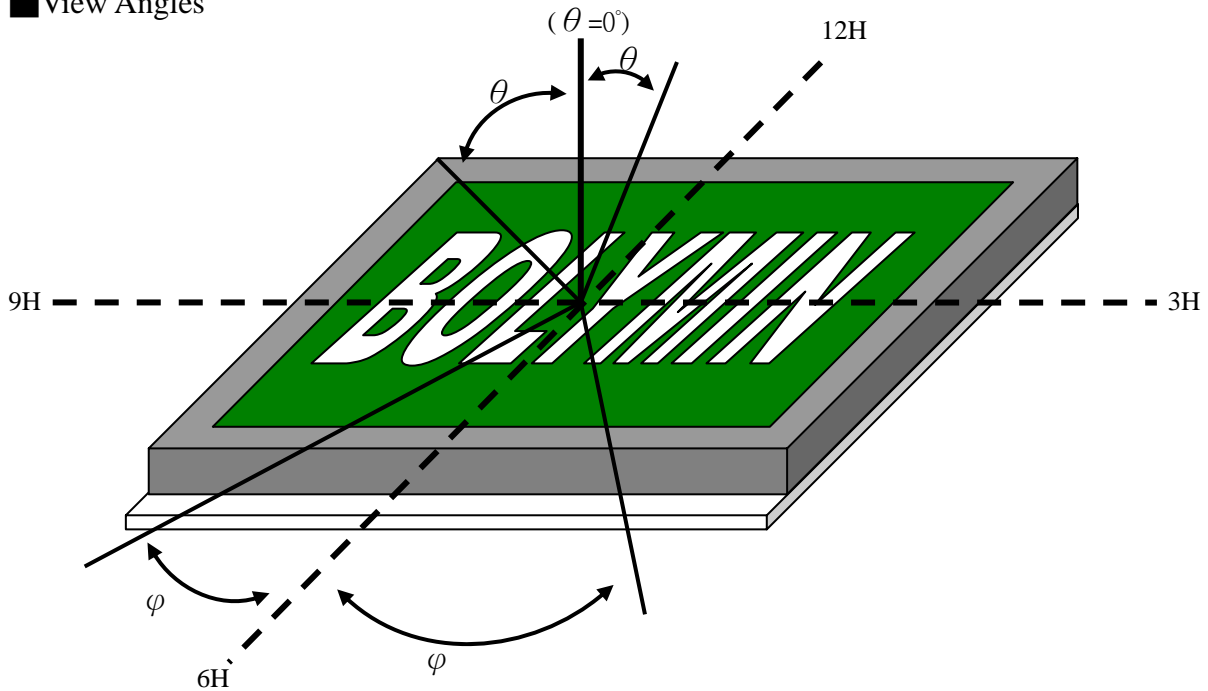
5. Optical Characteristics

a. STN

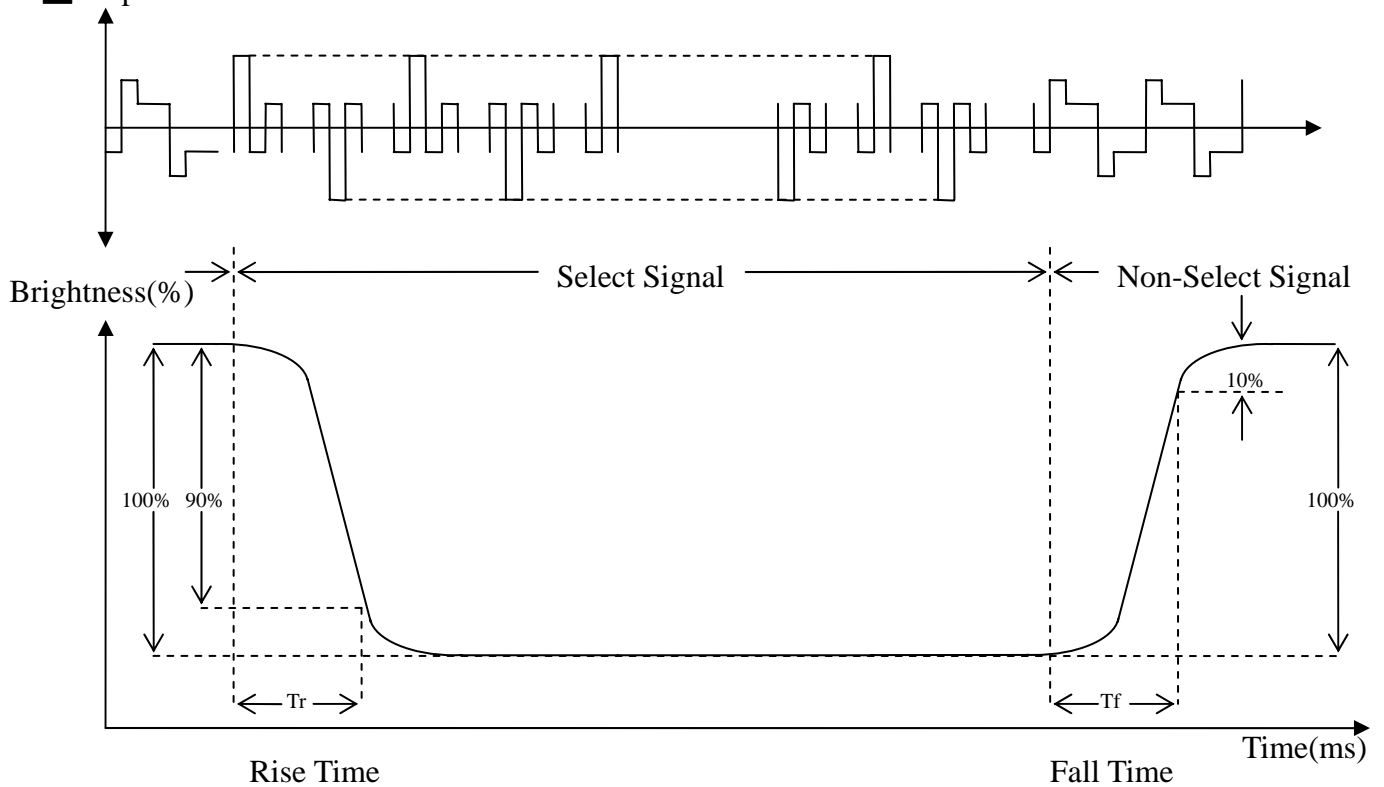
Item	Symbol	Condition	Min.	Typ.	Max.	Unit
View Angle	(V) θ	CR \geq 2	10	-	60	deg
	(H) φ	CR \geq 2	-45	-	45	deg
Contrast Ratio	CR	-	-	7.6	-	-
Response Time 25°C	T rise	-	-	28	400	ms
	T fall	-	-	330	400	ms

5.1 Definitions

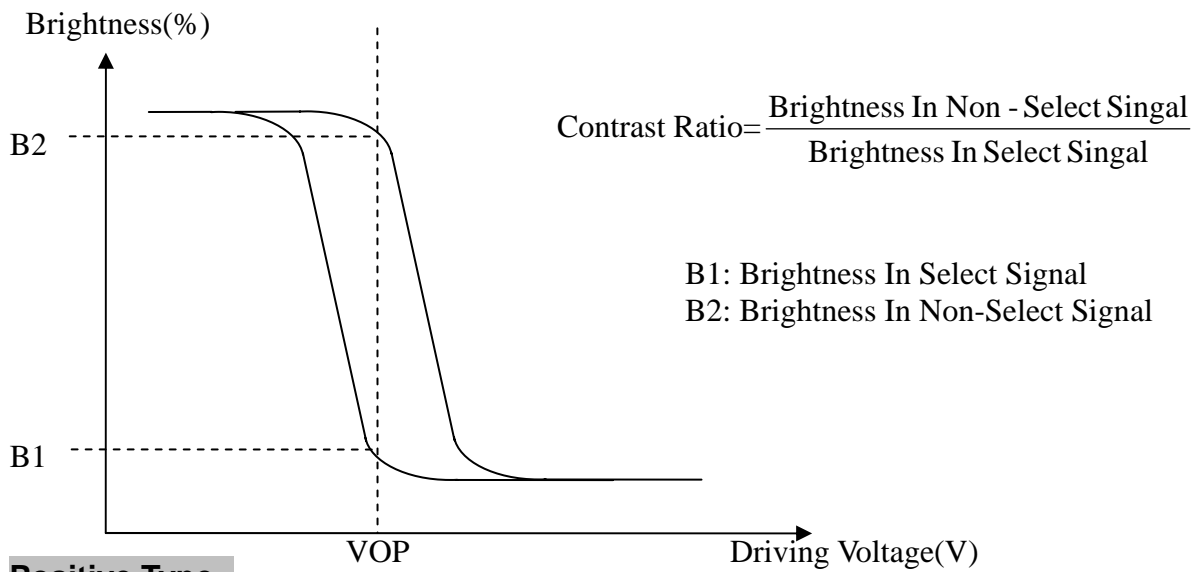
View Angles



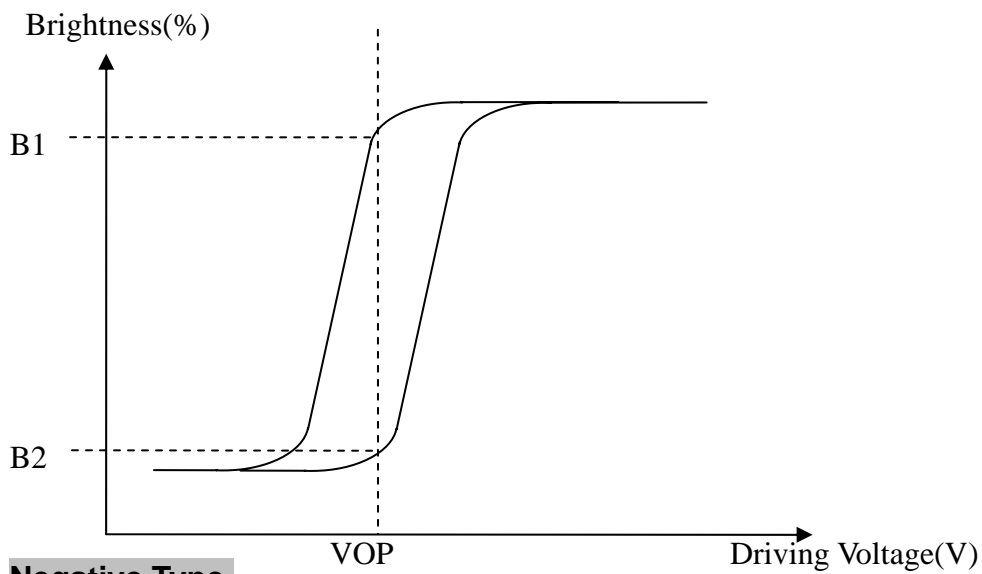
Response Time



■ Contrast Ratio



Positive Type

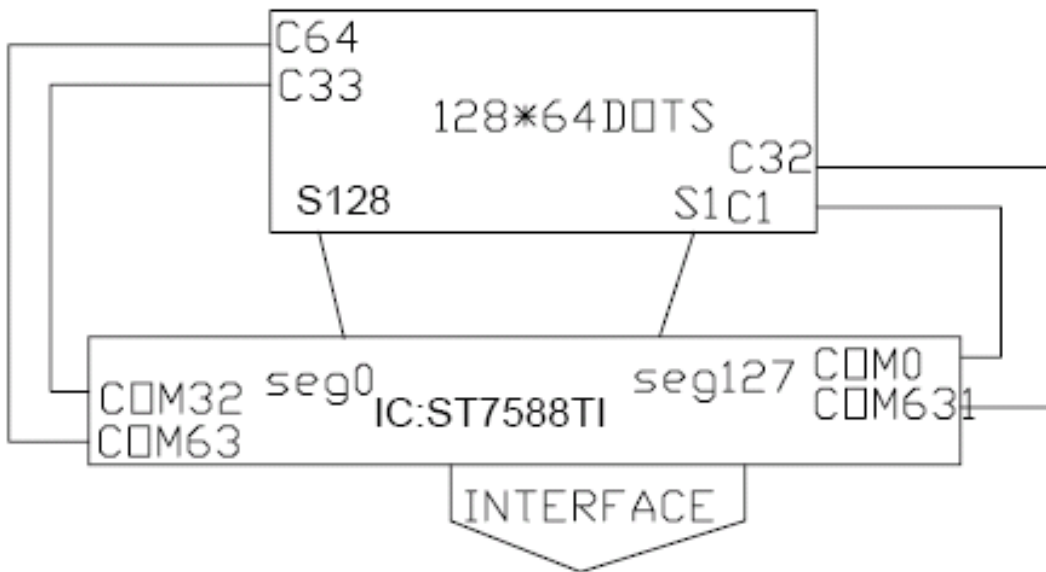


Negative Type

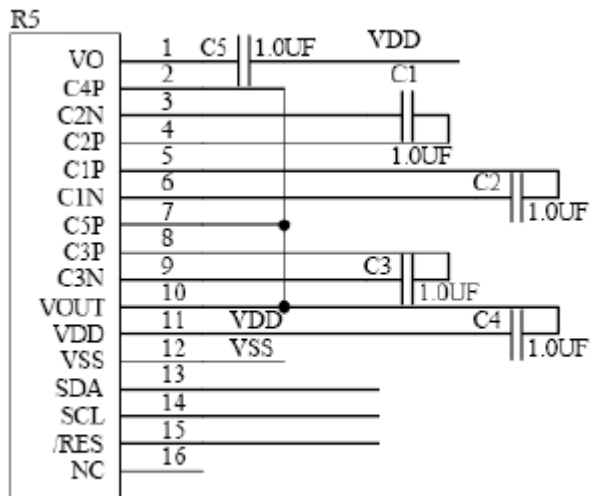
6. Interface Description

Pin No.	Symbol	Level	Description
1	Vo	-	LCD supply voltage
2	C4P	-	For voltage booster circuit capacitor connection pin for voltage converter
3	C2N	-	
4	C2P	-	
5	C1P	-	
6	C1N	-	
7	C5P	-	
8	C3P	-	
9	C3N	-	
10	VOUT	-	
11	VDD	3.0V	Power supply (+3.0V)
12	VSS	-	Ground
13	SDA	H/L	I2C input data
14	SCL	H/L	I2C input clock
15	/RESET	L	Reset : L=Enable H=Disable
16	NC	-	No connection

7. Block Diagram



8. Power Supply for LCD Module



9. Backlight Information

(1) LED edge/white

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition
Supply Current	I _{LED}	—	105	—	mA	V=3.1V
Supply Voltage	V	2.9	3.1	3.3	V	—
Reverse Voltage	V _R	—	—	8	V	—
LCM Surface Luminous	I _V	—	—	—	cd/m ²	I _{LED} =105mA
Life Time	—	—	20000	—	Hr.	V ≤ 3.1V
Color	White					

10. Timing Characteristics

10.1 Reset Timing

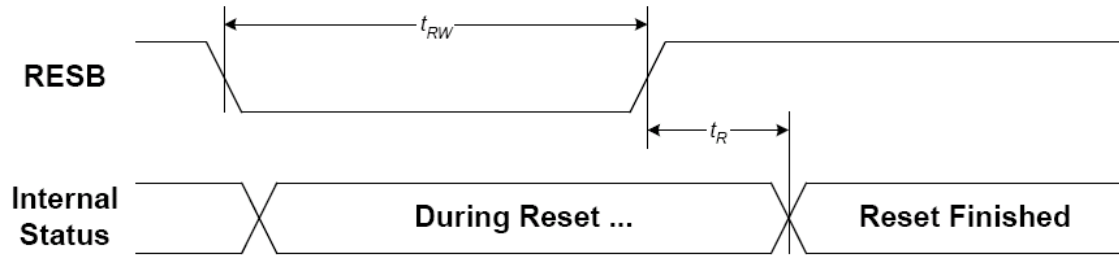


Figure 31

($V_{DD} = 3.3V$, $T_a = -30$ to $85\text{ }^{\circ}C$)

Item	Signal	Symbol	Condition	Rating			Units
				Min.	Typ.	Max.	
Reset time		t_R		--	--	400	ns
Reset "L" pulse width	/RES	t_{RW}		1200	--	--	

10.2 I2C Interface Timing

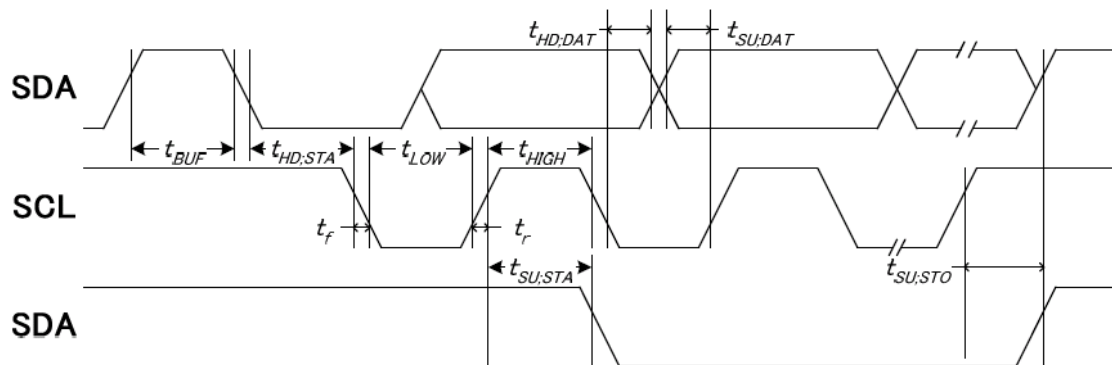
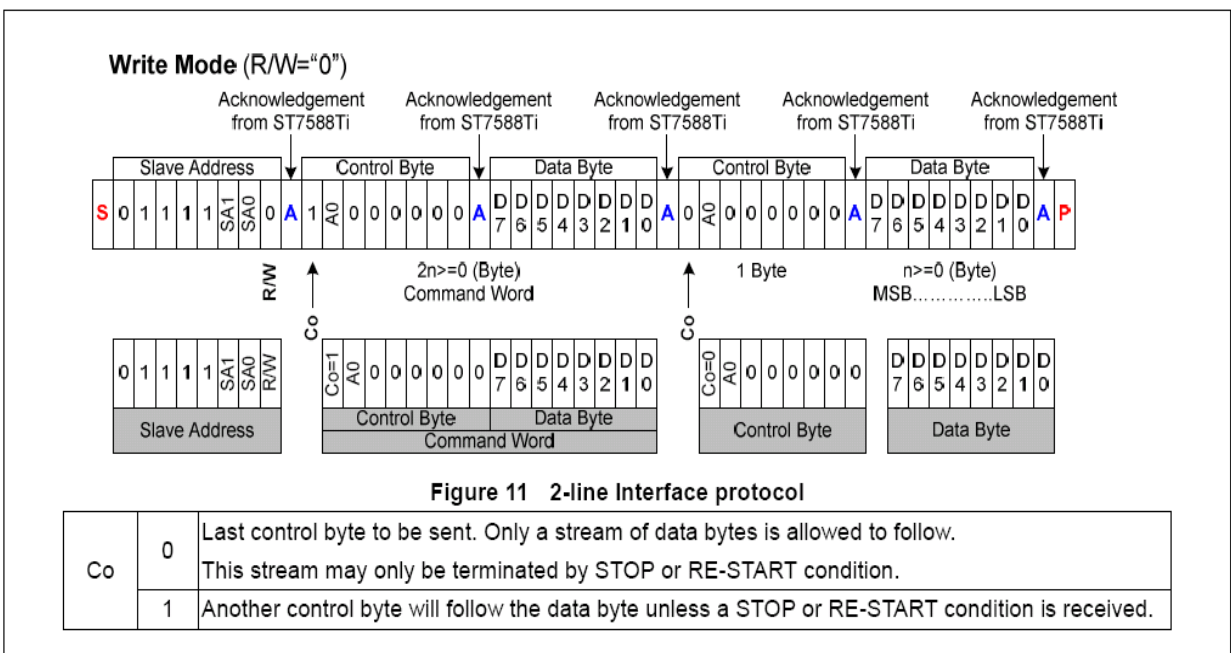
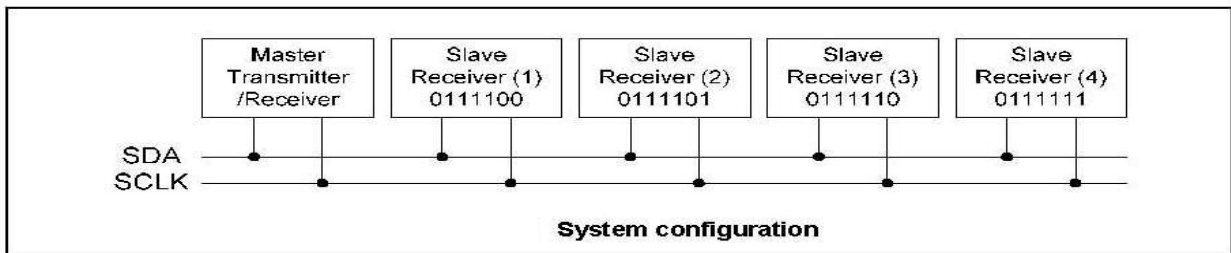
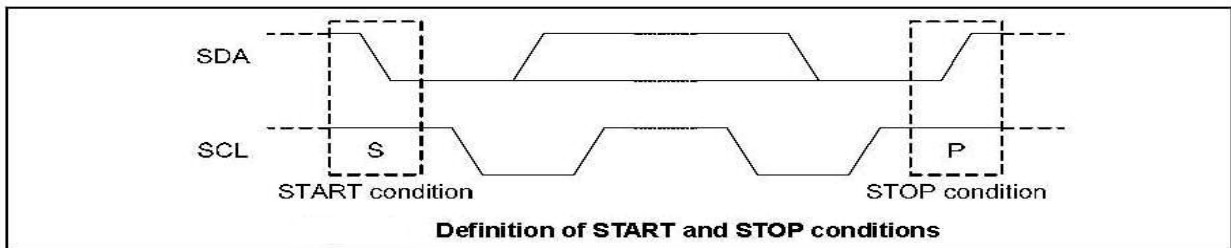
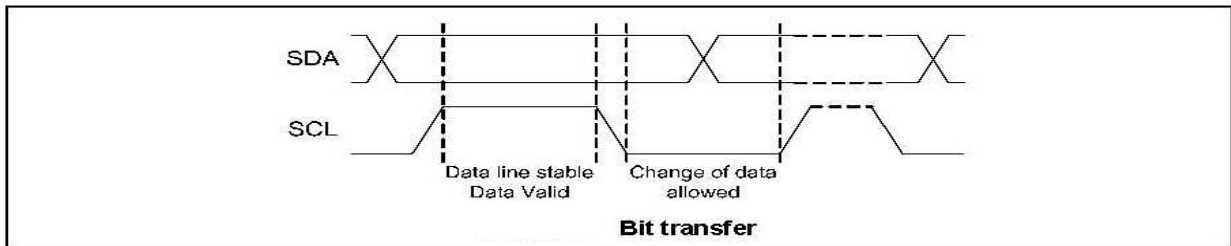
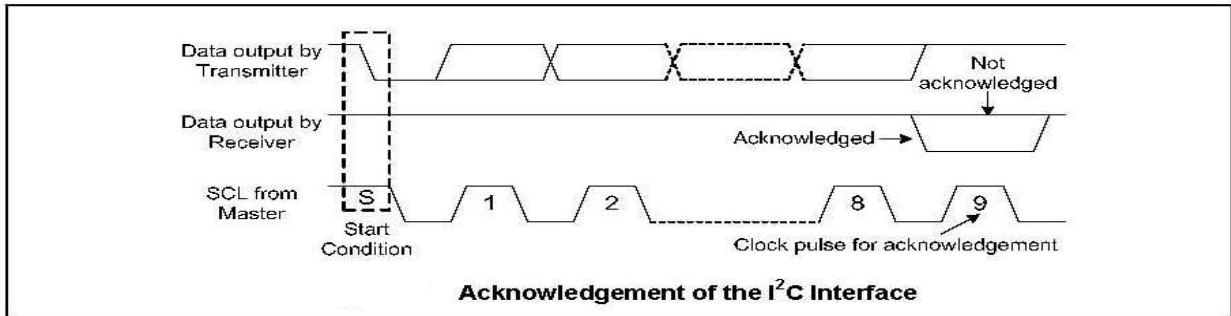


Figure 28

($V_{DD} = 3.3V$, $T_a = -30$ to $85\text{ }^{\circ}C$)

Item	Signal	Symbol	Condition	Rating		Units
				Min.	Max.	
SCL clock frequency	SCL	f_{SCLK}		DC	400	kHz
SCL clock low period	SCL	t_{LOW}		150	--	
SCL clock high period	SCL	t_{HIGH}		100	--	
Data set-up time	SDA	$t_{SU,Dat}$		90	--	
Data hold time	SDA	$t_{HD,Dat}$		40	--	
Setup time for a repeated START condition	SDA	$t_{SU,STA}$		70	--	
Start condition hold time	SDA	$t_{HD,STA}$		170	--	
Setup time for STOP condition		$t_{SU,STO}$		90	--	
BUS free time between a STOP and START condition	SCL	t_{BUF}		70	--	

10.3 I2C Interface



11. Instruction Description

INSTRUCTION	A0	R/W (WR)	COMMAND BYTE								DESCRIPTION
			D7	D6	D5	D4	D3	D2	D1	D0	
H independent instruction											
Write data	1	0	D7	D6	D5	D4	D3	D2	D1	D0	Write data to RAM
Read data	1	1	D7	D6	D5	D4	D3	D2	D1	D0	Read data to RAM
Read status byte	0	1	PD	0	V	D	E	MX	MY	DO	Read status byte
Function Set	0	0	0	0	1	MX	MY	PD	H1	H0	Mirror X, Mirror Y, Power Down, Extended table

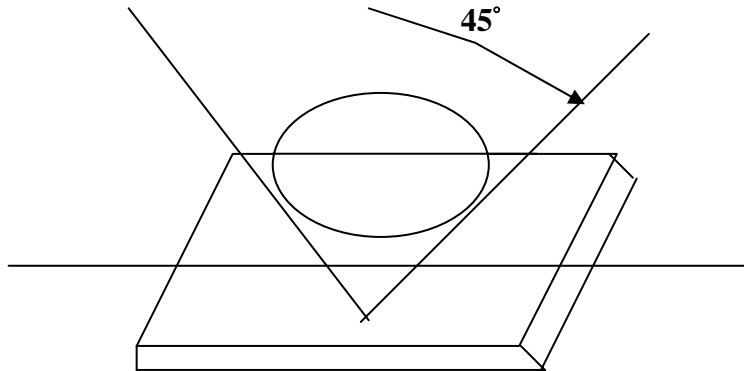
INSTRUCTION	A0	R/W (WR)	COMMAND BYTE								DESCRIPTION
			D7	D6	D5	D4	D3	D2	D1	D0	
H[1:0]=[0:0]											
Set V0 (V _{OP}) range	0	0	0	0	0	0	0	1	0	PRS	V0 (V _{OP}) range LH select
END	0	0	0	0	0	0	0	1	1	0	Release read/modify/write
Read/modify/write	0	0	0	0	0	0	0	1	1	1	RAM address at R:+0, W:+1
Display control	0	0	0	0	0	0	1	D	0	E	Sets display configuration
SI3-8bit data (L)&start	0	0	0	1	0	1	DA3	DA2	DA1	DA0	Set the number of data bytes, Low-bit (8 bit 3-line SPI)
SI3-8bit data (M)	0	0	0	1	1	0	DA7	DA6	DA5	DA4	Set the number of data bytes, Middle-bit (8 bit 3-line SPI)
SI3-8bit data (H)	0	0	0	1	1	1	0	DA10	DA9	DA8	Set the number of data bytes, High-bit (8 bit 3-line SPI)
Set Y address	0	0	0	1	0	0	Y3	Y2	Y1	Y0	Set Y address of RAM 0 ≤ Y ≤ 9
Set X Address (L)	0	0	1	1	1	0	X3	X2	X1	X0	Set X address of RAM, Low-bit. 0 ≤ X ≤ 131
Set X Address (H)	0	0	1	1	1	1	X7	X6	X5	X4	Set X address of RAM, High-bit. 0 ≤ X ≤ 131
H[1:0]=[0:1]											
Display configuration	0	0	0	0	0	0	1	DO	0	V	Top/bottom row mode set data order
Bias system	0	0	0	0	0	1	0	BS2	BS1	BS0	Sets bias system (BSx)
Set V0 (V _{OP})	0	0	1	V _{OP6}	V _{OP5}	V _{OP4}	V _{OP3}	V _{OP2}	V _{OP1}	V _{OP0}	Write V0 (V _{OP}) to register

INSTRUCTION	A0	R/W (WR)	COMMAND BYTE								DESCRIPTION
			D7	D6	D5	D4	D3	D2	D1	D0	
H[1:0]=[1:0]											
Set Partial screen mode	0	0	0	0	0	0	0	1	0	PS	PS=1: Enable Partial screen mode.
Partial Display	0	0	0	0	0	0	1	0	0	WS	Set partial screen size
Set Partial Display part	0	0	0	0	0	1	DP3	DP2	DP1	DP0	Set display area for partial screen mode
Set Start line	0	0	1	S6	S5	S4	S3	S2	S1	S0	Specify the initial display line to realize vertical scrolling
H[1:0]=[1:1]											
RESET	0	0	0	0	0	0	0	0	1	1	Software reset
High Power Mode	0	0	1	0	1	1	0	HP	0	0	High Power Mode SET
Frame	0	0	0	0	0	0	1	FR2	FR1	FR0	Frame rate control
N line inversion	0	0	0	1	0	NL4	NL3	NL2	NL1	NL0	Sets N line inversion

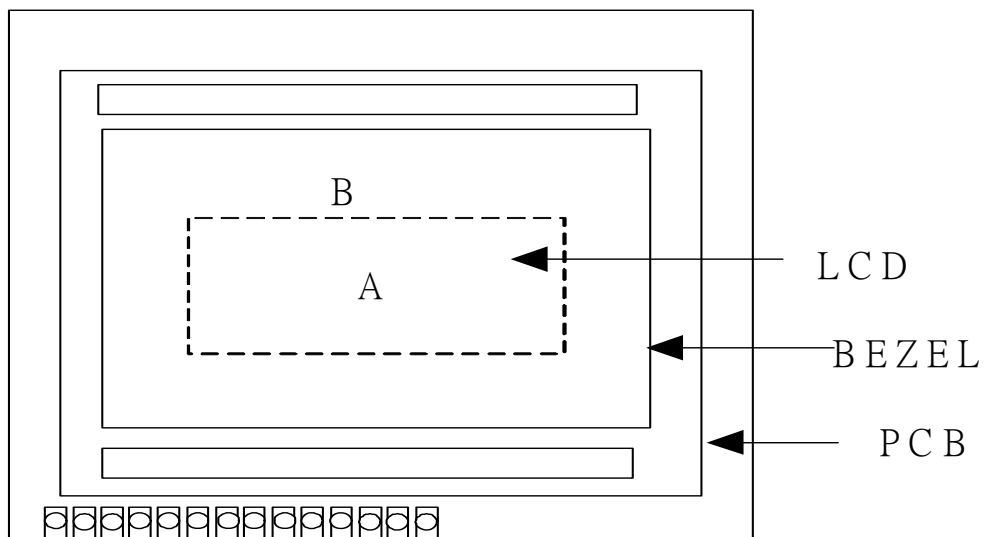
12. Quality Assurance

12.1 Inspection conditions

The LCD shall be inspected under 40W white fluorescent light.



Definition of applicable Zones

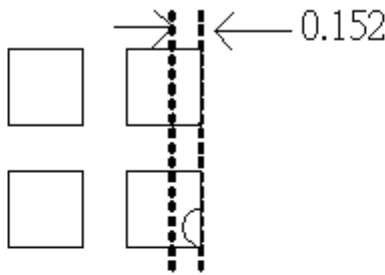
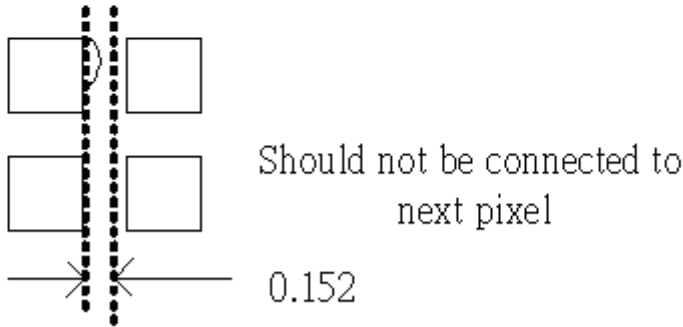
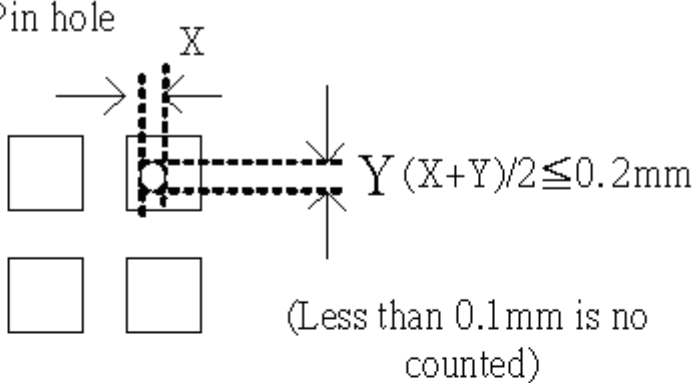
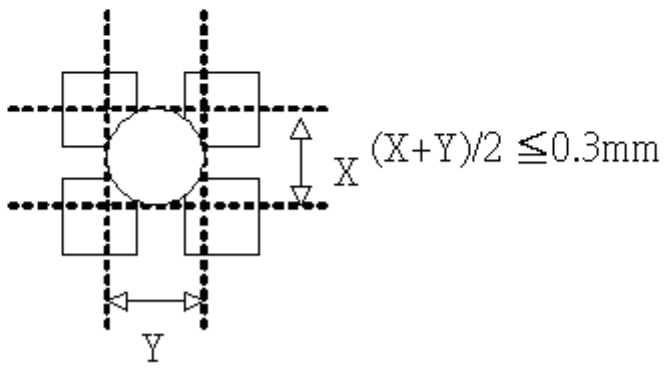


A : Display Area

B : Non-Display Area

12.2 Inspection Parameters

NO.	Parameter	Criteria																												
1	Black or White spots	<table border="1"> <thead> <tr> <th rowspan="2">Zone Dimension</th> <th colspan="2">Acceptable Number</th> <th rowspan="2">Class Of Defects</th> <th rowspan="2">Acceptable Level</th> </tr> <tr> <th>A</th> <th>B</th> </tr> </thead> <tbody> <tr> <td>$D < 0.15$</td> <td>*</td> <td>*</td> <td rowspan="4">Minor</td> <td rowspan="4">2.5</td> </tr> <tr> <td>$0.15 \leq D \leq 0.2$</td> <td>4</td> <td>4</td> </tr> <tr> <td>$0.2 \leq D \leq 0.25$</td> <td>2</td> <td>2</td> </tr> <tr> <td>$D \leq 0.3$</td> <td>0</td> <td>1</td> </tr> </tbody> </table> <p>$D = (\text{Long} + \text{Short})/2$ *: Disregard</p>	Zone Dimension	Acceptable Number		Class Of Defects	Acceptable Level	A	B	$D < 0.15$	*	*	Minor	2.5	$0.15 \leq D \leq 0.2$	4	4	$0.2 \leq D \leq 0.25$	2	2	$D \leq 0.3$	0	1							
Zone Dimension	Acceptable Number			Class Of Defects	Acceptable Level																									
	A	B																												
$D < 0.15$	*	*	Minor	2.5																										
$0.15 \leq D \leq 0.2$	4	4																												
$0.2 \leq D \leq 0.25$	2	2																												
$D \leq 0.3$	0	1																												
2	Scratch, Substances	<table border="1"> <thead> <tr> <th colspan="2">Zone X(mm) Y(mm)</th> <th colspan="2">Acceptable Number</th> <th rowspan="2">Class Of Defects</th> <th rowspan="2">Acceptable Level</th> </tr> <tr> <th></th> <th></th> <th>A</th> <th>B</th> </tr> </thead> <tbody> <tr> <td>*</td> <td>$0.04 \geq W$</td> <td>*</td> <td>*</td> <td rowspan="4">Minor</td> <td rowspan="4">2.5</td> </tr> <tr> <td>$3.0 \geq L$</td> <td>$0.06 \geq W$</td> <td>4</td> <td>4</td> </tr> <tr> <td>$2.0 \geq L$</td> <td>$0.08 \geq W$</td> <td>2</td> <td>3</td> </tr> <tr> <td>—</td> <td>$0.1 < W$</td> <td>0</td> <td>1</td> </tr> </tbody> </table> <p>X: Length Y: Width *: Disregard Total defects should not exceed 4/module</p>	Zone X(mm) Y(mm)		Acceptable Number		Class Of Defects	Acceptable Level			A	B	*	$0.04 \geq W$	*	*	Minor	2.5	$3.0 \geq L$	$0.06 \geq W$	4	4	$2.0 \geq L$	$0.08 \geq W$	2	3	—	$0.1 < W$	0	1
Zone X(mm) Y(mm)		Acceptable Number		Class Of Defects	Acceptable Level																									
		A	B																											
*	$0.04 \geq W$	*	*	Minor	2.5																									
$3.0 \geq L$	$0.06 \geq W$	4	4																											
$2.0 \geq L$	$0.08 \geq W$	2	3																											
—	$0.1 < W$	0	1																											
3	Air Bubbles (between glass & polarizer)	<table border="1"> <thead> <tr> <th rowspan="2">Zone Dimension</th> <th colspan="2">Acceptable Number</th> <th rowspan="2">Class Of Defects</th> <th rowspan="2">Acceptable Level</th> </tr> <tr> <th>A</th> <th>B</th> </tr> </thead> <tbody> <tr> <td>$D \leq 0.2$</td> <td>*</td> <td>*</td> <td rowspan="3">Minor</td> <td rowspan="3">2.5</td> </tr> <tr> <td>$0.2 < D \leq 0.5$</td> <td>2</td> <td>*</td> </tr> <tr> <td>$0.5 < D$</td> <td>0</td> <td>1</td> </tr> </tbody> </table> <p>*: Disregard Total defects shall not exceed 3/module.</p>	Zone Dimension	Acceptable Number		Class Of Defects	Acceptable Level	A	B	$D \leq 0.2$	*	*	Minor	2.5	$0.2 < D \leq 0.5$	2	*	$0.5 < D$	0	1										
Zone Dimension	Acceptable Number			Class Of Defects	Acceptable Level																									
	A	B																												
$D \leq 0.2$	*	*	Minor	2.5																										
$0.2 < D \leq 0.5$	2	*																												
$0.5 < D$	0	1																												

4	Uniformity	<p>(1) Pixel shape (with Dent)</p>  <p>(2) Pixel shape (With Projection)</p>  <p>(3) Pin hole</p>  <p>(4) Deformation</p>  <p>Total acceptable number : 1/pixel,5/cell</p>
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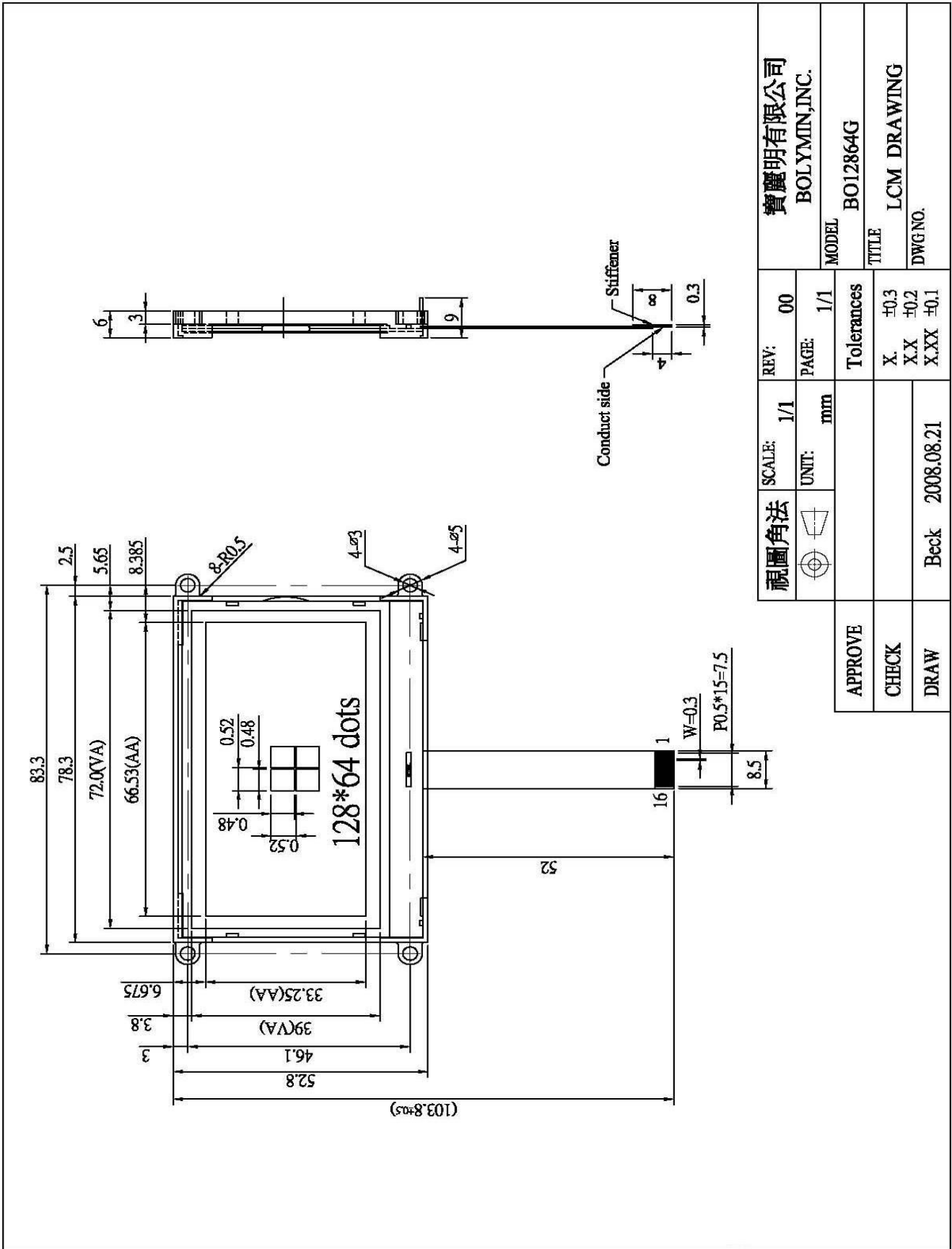
13. Reliability

■ Content of Reliability Test

Environmental Test				
No.	Test Item	Content of Test	Test Condition	Applicable Standard
1	High Temperature storage	Endurance test applying the high storage temperature for a long time.	70°C 96hrs	—
2	Low Temperature storage	Endurance test applying the high storage temperature for a long time.	-20°C 96hrs	—
3	High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	80°C 96hrs	—
4	Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-30°C 96hrs	—
5	Humidity Test	Endurance test applying the high humidity storage for a long time.	40°C, 90%RH 96hrs	—
6	Thermal Shock Test	Endurance test applying the low and high temperature cycle. <div style="text-align: center;"> -30°C 25°C 80°C \longleftarrow ————— \longrightarrow 30min 5min 30min 1 cycle </div>	-30°C / 80°C 5 cycles	—
7	Vibration test	Endurance test applying the vibration during transportation and using.	Total Fixed Amplitude: 1.5mm Vibration Frequency : 10~55Hz One cycle 60 seconds to 3 direction of X,Y,Z for each 15minutes	—

***Supply voltage for logic system=5V. Supply voltage for LCD system = Operating voltage at 25°C

14. Appendix (Drawing)



視圖角法	SCALE: 1/1	REV: 00	寶麗明有限公司
	UNIT: mm	PAGE: 1/1	BOLYMIN, INC.
APPROVE		Tolerances	MODEL BO12864G
CHECK		X. ±0.3	TITLE LCM DRAWING
DRAW	Beck 2008.08.21	X.X ±0.2	DWG NO.
		X.XX ±0.1	